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SPECIFICATIONS

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Product Name		Multi-layer Chip Ferrite Bead		
Sunlord Part N	umber	S	Z0603K Series	
Customer Part	Number			
[New Released, Revised] SPEC No.: SZ0204210000 [This SPEC is total 9 pages including specifications and appendix.] [ROHS, Halogen-Free and SVHC Compliant Parts]				
	Approved By	Checked By	Issued By	
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el: 0086-755-298323 (For Customer app Qualification Status:	oroval Only】 □ Full	☐ Restricted	Date: Rejected	
el: 0086-755-298323	proval Only]	☐ Restricted	Date: Rejected	Checked By

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Specifications for Multi-layer Chip Ferrite Bead

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【Version change history】

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	1	New release	/	JiaMing He

[Caution]

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

- 1. Aircraft equipment
- 2. Aerospace equipment
- 3. Undersea equipment
- 4. nuclear control equipment
- 5. military equipment
- 6. Power plant equipment
- 7. Medical equipment
- 8. Transportation equipment (automobiles, trains, ships, etc.)

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- 9. Traffic signal equipment
- 10. Disaster prevention / crime prevention equipment
- 11. Data-processing equipment
- 12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

1. Scope

This specification applies to SZ0603K Series of multi-layer ferrite chip bead.

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2. Product Description and Identification (Part Number)

1) Description:

SZ0603K Series of multi-layer ferrite chip bead.

2) Product Identification (Part Number)

<u>SZ</u>	<u>0603</u>	<u>K</u>	<u>220</u>	<u>T</u>	<u>F</u>
1	2	3	4	(5)	6

① Type		
SZ	For High Speed	

3	Material Code	
	K	

5	Packing	
Т	Tape Carrier Package	

6	HSF Products	
На	zardous Substance Free Products	

② External	Dimensions	(LXW)[mm]	
0603 [0201]		0.6 X 0.3	

④ Nor	ninal	Impedance
Example		Nominal Value
300		30Ω
121		120Ω

3. Electrical Characteristics

Please refer to Appendix A (Page 10).

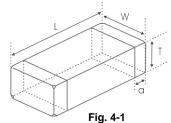
- 1) Operating and storage temperature range (individual chip without packing): -55 $^{\circ}$ C ~ +125 $^{\circ}$ C.
- 2) Storage temperature range (packaging conditions):-10°C~+40°C and RH 70% (Max.)

4. Shape and Dimensions

Type 0603

[0201]

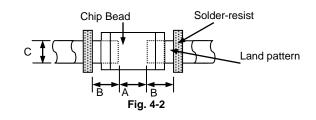
- 1) Dimensions and recommended PCB pattern for reflow soldering: See Fig.4-1, Fig.4-2 and Table 4-1.
- 2) Structure: See Fig. 4-3 and Fig. 4-4.



 0.6 ± 0.05

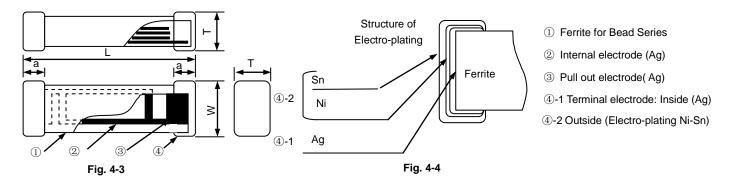
 $[.024 \pm 0.002]$

[Table 4-1]



Unit: mm [inch]

[lable 4-	',		Offic. Hilli [ii	ilonj	
W	Т	а	Α	В	С
0.3±0.05 [.012±.002]	0.3±0.05 [.012±.002]	0.15±0.05 [.006±.002]	0.2~0.3	0.2~0.3	0.3~0.35



Material Information: See Table 4-2.

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[Table 4-2]

Code	Part Name	Material Name
1	Ferrite Body	Ferrite Powder
2	Inner Coils	Silver Paste
3	Pull-out Electrode (Ag)	Silver Paste
4 -1	Terminal Electrode: Inside Ag	Termination Silver Composition
4 -2	Electro-Plating: Ni/Sn plating	Plating Chemicals

5. **Test and Measurement Procedures**

5.1 Test Conditions

- 5.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:
 - Ambient Temperature: 20±15°C
 - Relative Humidity: 65±20% b.
 - Air Pressure: 86kPa to 106kPa
- 5.1.2 If any doubt on the results, measurements/tests should be made within the following limits:
 - Ambient Temperature: 20±2℃
 - Relative Humidity: 65±5% b.
 - Air Pressure: 86kPa to 106kPa

5.2 Visual Examination

a. Inspection Equipment: 20x magnifier

5.3 Electrical Test

- 5.3.1 DC Resistance (DCR)
 - Refer to Appendix A. a.
 - Test equipment (Analyzer): High Accuracy Milliohmmeter-HP4338B or equivalent. b.

5.3.2 Impedance (Z)

- a. Refer to Appendix A.
- Test equipment: High Accuracy RF Impedance /Material Analyzer-E4991A or equivalent.

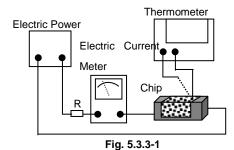
Test fixture: HP16197A for 0603, HP16192A for 1005/1608/2012/3216.

Test signal: -20dBm or 50mV

C. Test frequency refers to Appendix A.

5.3.3 Rated Current

- a. Refer to Appendix A.
- b. Test equipment (see Fig.5.3.3-1): Electric Power, Electric current meter, Thermometer.
- c. Measurement method (see Fig. 5.3.3-1):
 - 1. Set test current to be 0 mA.
 - 2. Measure initial temperature of chip surface.
 - 3. Gradually increase voltage and measure chip temperature for corresponding current.
- against chip initial surface temperature (Ta) (see Fig. 5.3.3-2)



Temperature (°C) +20 Ta 0 Rated current

Fig. 5.3.3-2

5.4 Reliability Test

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Items	Requirements	Test Methods and Remarks
5.4.1 Terminal Strength	No removal or split of the termination or other defects shall occur. Chip Mounting Pad Glass Epoxy Board Fig.5.4.1-1	Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.1-1) using leadfree solder. Then apply a force in the direction of the arrow. Note for 0603 series, Keep time: 10±1s. Speed: 1.0mm/s.
5.4.2 Resistance to Flexure	Unit: mm [inch] Type a b c 0603[0201] 0.25 0.8 0.3	 Solder the bead to the test jig (glass epoxy board shown in Fig. 5.4.2-1) Using a leadfree solder. Then apply a force in the direction shown Fig. 5.4.2-2. Flexure: 2mm. Pressurizing Speed: 0.5mm/sec. Keep time: 30 sec.
	© 04.5 © 100 Fig. 5.4.2-1	Flexure Fig. 5.4.2-2
5.4.3 Vibration	1 No visible mechanical damage. 2 Impedance change: within ±20% Cu pad Solder mask Glass Epoxy Board Fig. 5.4.3-1	 Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using leadfree solder. The bead shall be subjected to a simple harmonic motion having total amplitude of 1.5 mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz. The frequency range from 10 to 55 Hz and return to 10 Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions (total of 6 hours).
5.4.4 Dropping	 No visible mechanical damage. Impedance change: within ±20%. 	Drop chip bead 10 times on a concrete floor from a height of 100 cm.
5.4.5 Temperature	Impedance change should be within ±20% of initial value measuring at 20°C.	Temperature range: -55°C ~ 125°C. Reference temperature: +20°C.
5.4.6 Solderability	No visible mechanical damage. Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others	 Solder temperture:240±2℃ Duration: 3 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight.
5.4.7 Resistance to Soldering Heat	 No visible mechanical damage. Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others Impedance change: within ±20%. 	 Solder temperature :260±3°C Duration: 5 sec. Solder: Sn/3.0Ag/0.5Cu. Flux: 25% Resin and 75% ethanol in weight. The chip shall be stabilized at normal condition for 1~2 hours before measuring.

5.4.8 Thermal Shock	① No mechanical damage. ② Impedance change: Within ±20%. 125°C Ambient Temperature -55°C Fig. 5.4.8-1 20sec. (max.)	 Temperature, Time: (See Fig.5.4.8-1) -55℃ for 30±3 min→125℃ for 30±3min. Transforming interval: Max. 20 sec. Tested cycle: 100 cycles. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.9 Resistance to Low Temperature	 No mechanical damage. Impedance change: within ±20%. 	 Temperature: -55±2°C Duration: 1000⁺²⁴ hours. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.10 Resistance to High Temperature	 No mechanical damage. Impedance change: within ±20%. 	 Temperature: 125±2°C Duration: 1000⁺²⁴ hours. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.11 Damp Heat (Steady States)	No mechanical damage. Impedance change: Within ±20%.	 Temperature: 60±2℃ Humidity: 90% to 95% RH. Duration: 1000+24 hours. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.12 Loading Under Damp Heat	No visible mechanical damage. Impedance change: within ±20%.	 Temperature: 60±2°C Humidity: 90% to 95% RH. Duration: 1000+24 hours. Applied current: Rated current. The chip shall be stabilized at normal condition for 1~2 hours before measuring.
5.4.13 Loading at High Temperature (Life Test)	No visible mechanical damage. Impedance change: within ±20%.	 Temperature: 125±2°C Duration: 1000⁺²⁴ hours. Applied current: Rated current. The chip shall be stabilized at normal condition for 1~2 hours before measuring.

Packaging, Storage

6.1 Packaging

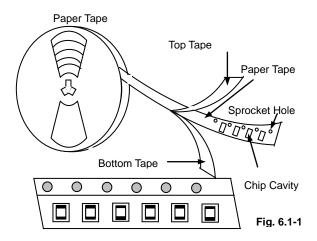
Tape Carrier Packaging:

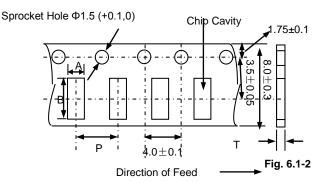
Packaging code: T

- Tape carrier packaging are specified in attached figure Fig.6.1-1~3
- Tape carrier packaging quantity please see the following table:

Type	0603[0201]		
T(mm)	0.3±0.15		
Tape	Paper Tape		
Quantity	15K		

(1) Taping Drawings (Unit: mm)



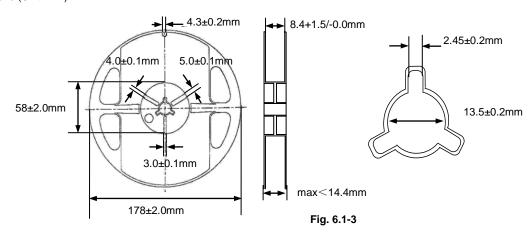


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Paper Tape

Type	Α	В	Р	T max
0603[0201]	0.40±0.1	0.70±0.1	2.0±0.1	0.55

3) Reel Dimensions (Unit: mm)



6.2 Storage

- a. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40 °C or less and 70% RH or less.
- b. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCl, sulfurous gas of H₂S).
- c. Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- d. Solderability specified in Clause 5.4.6 shall be guaranteed for 6 months from the date of delivery on condition that they are stored at the environment specified in Clause 3. For those parts, which passed more than 6 months shall be checked solder-ability before use.

Recommended Soldering Technologies

7.1 Re-flowing Profile:

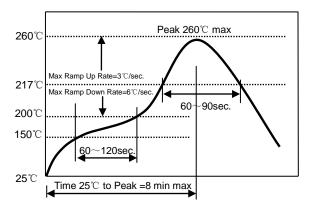
- Preheat condition: 150 ~200 °C/60~120sec.
- Allowed time above 217°C: 60~90sec.
- Δ Max temp: 260°C
- Max time at max temp: 10sec. \wedge
- \triangle Solder paste: Sn/3.0Ag/0.5Cu
- Allowed Reflow time: 2x max

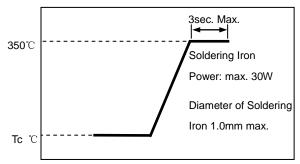
[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]



- △ Iron soldering power: Max.30W
- Pre-heating: 150 °C / 60sec.
- \wedge Soldering Tip temperature: 350 ℃ Max.
- Δ Soldering time: 3sec Max.
- Δ Solder paste: Sn/3.0Ag/0.5Cu
- Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]





Appendix A: Electrical Characteristics

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I. SZ0603K Series of Beads

Part Number	Impedance (Ω)	Z Test Freq. (MHz)	DCR (Ω) Max.	Ir (mA) Max.	Thickness (mm) [inch]
		(1011 12)	(SZ) IVIAA.	(IIIA) IVIAA.	(IIIII) [IIICII]
SZ0603K100TF	10±5	100	0.40	300	
SZ0603K220TF	22±25%	100	0.50	200	
SZ0603K470TF	47±25%	100	0.70	200	0.3±0.05 [.012±.002]
SZ0603K750TF	75±25%	100	1.00	200	[.0121.002]
SZ0603K121TF	120±25%	100	1.50	100	

Impedance Frequency Characteristics

